Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/767,257	FREDERIKSEN ET AL.
Examiner	Art Unit

3744

Chen-Wen Jiang

SEARCHED					
Class	Subclass	Date	Examiner		
62	150				
	176.1				
	324.6				
236	74R				
	44C				
	42	11/30/2005	CJ		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Searched Inventor Searched	11/30/2005	Cl		